

Non-Collinear Phase in Rare-Earth Iron Garnet Films near the Compensation Temperature

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An essential condition for liquid-phase epitaxy (LPE) of samples was the need to provide the possibility of magneto-optical observation of magnetic phases. This condition required the introduction of sufficiently large amount, on the order of 1 f.u., of magneto-optically active Bi³⁺ ions into the film composition. To ensure the inclusion of Bi³⁺ ions in such an amount, the Blenk-Nielson coefficients [19] were chosen in the range from 13 to 15 for R₁ and from 7 to 12 for R₄ (Table S1). The remaining coefficients R₂ and R₃ were selected in accordance with the required Ga concentration during the synthesis of films with given values of the magnetic compensation temperature. The melt composition for LPE synthesis films (BiGd)₃(FeGa)₅O₁₂ and (BiYLu)₃(FeGa)₅O₁₂ is given in Table S2. The optimal growth temperature T_{growth} and rate V_{growth} are presented in Table S1.

Table S1. Main LPE growth parameters.

No.	Sample	R ₁	R ₄	T _{growth} , °C	V _{growth} , mk/min	h, mkm
1	(BiGd) ₃ (FeGa) ₅ O ₁₂	15.5	6.9	743.3	0.36	5.1
2	(BiYLu) ₃ (FeGa) ₅ O ₁₂	14	12	816.5	0.62	4.9

Table S2. Melt composition in molar percent [mol%].

Sample	Bi ₂ O ₃	PbO	Li ₂ CO ₃	Fe ₂ O ₃	Ga ₂ O ₃	Al ₂ O ₃	Y ₂ O ₃	Lu ₂ O ₃	Gd ₂ O ₃
(BiGd) ₃ (FeGa) ₅ O ₁₂	39.45	53.57	-	6.1	0.36	0.1	-	-	0.42
(BiYLu) ₃ (FeGa) ₅ O ₁₂	68.25	-	19.58	10.2	1.81	-	0.34	0.51	-

Single-crystal substrates (GdCa)₃(GaMgZr)₅O₁₂ and Gd₃Ga₅O₁₂ were used for the epitaxial synthesis of (BiGd)₃(FeGa)₅O₁₂ and (BiYLu)₃(FeGa)₅O₁₂ films, respectively. All substrates had the (111) plane orientation.

The structural characterization of films were ascertained using X-ray diffraction (XRD) with Cu-K α radiation (1.5406 Å). The mismatch parameter between the crystalline cells of the films and the substrates Δa did not exceed 0.008 Å for both compounds.

The crystalline quality of the synthesized films was also estimated from the half-width of the rocking curves FWHM, the value of which did not exceed 20" for both compounds. As an example, Figure S1 shows the rocking curve for the film (BiGd)₃(FeGa)₅O₁₂ (888) peak with FWHM 16.92".

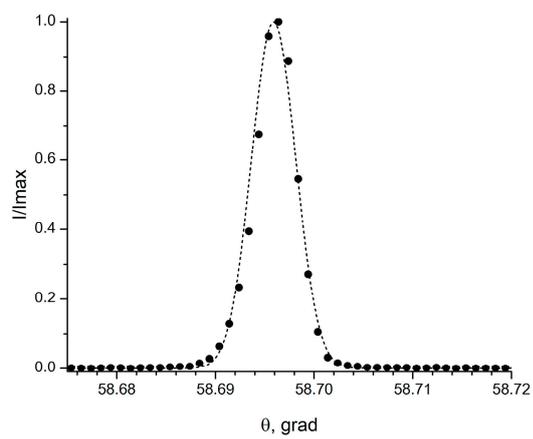


Figure S1. Rocking curve of the $(\text{BiGd})_3(\text{FeGa})_5\text{O}_{12}$ (888) peak.